

FORM PTO-1449 (Modified)		ATTY. DOCKET NO. FIS920030246	SERIAL NO. Unassigned
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT		APPLICANT: Bruce B. Doris, et al.	
(Use several sheets if necessary)		FILING DATE: Concurrently Herewith	GROUP: Unassigned

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPRO.)
S	6,228,694 B1	5/8/2001	Doyle et al.			
S	6,406,973 B1	6/18/2002	Lee			
S	6,281,532 B1	8/28/2001	Doyle et al.			
S	5,683,934	11/4/97	Candelaria			
S	6,368,931 B1	4/9/2002	Kuhn, et al.			
S	5,310,446	5/10/94	Konishi et al.			
S	4,853,076	8/1/89	Tsaur et al.			
S	US 2002/0090791 A1	7/11/2002	Doyle et al.			
S	US 2002/0074598 A1	6/20/2002	Doyle et al.			
S	6,509,618 B2	7/21/2003	Jan et al.			
S	6,476,462 B2	11/5/2002	Shimizu et al.			
S	6,362,082 B1	3/26/2002	Doyle et al.			
S	6,228,694 B1	5/8/2001	Doyle et al.			
S	5,565,697	10/15/96	Asakawa et al.			
S	US 2003/0040158 A1	2/27/2003	Saitoh			
S	US 2002/0086472 A1	7/4/2002	Roberds et al.			
S	6,521,964 B1	2/18/2003	Jan et al.			
S	6,506,652	01/14/03	Jan, et al.			

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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
						YES NO

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S	5,081,513	1/14/1992	Jackson, et al.			
S	3,602,841	8/31/1971	McGroddy			
S	6,531,740	3/11/2003	Bosco, et al.			
S	6,531,369	3/11/2003	Ozkan, et al.			
S	6,501,121	12/31/2002	Yu, et al.			
S	6,498,358	12/24/2002	Lach, et al.			
S	6,493,497	12/10/2002	Ramdani, et al.			
S	6,403,975	6/11/2002	Brunner, et al.			
S	6,361,885	3/26/2002	Chou			
S	6,255,169	7/3/2001	Li, et al.			
S	6,246,095	6/12/2001	Brady, et al.			
S	6,165,383	12/26/2000	Chou			
S	6,133,071	10/17/2000	Nagai			
S	6,046,464	4/4/2000	Schetzina			
S	6,025,280	2/15/2000	Brady, et al.			

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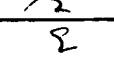
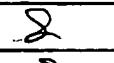
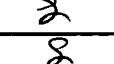
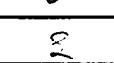
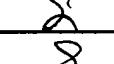
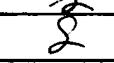
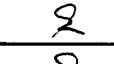
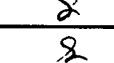
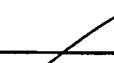
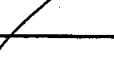
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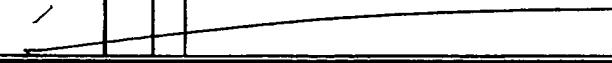
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EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPRO.)
	5,940,736	8/17/1999	Brady, et al.			
	5,880,040	3/9/1999	Sun, et al.			
	5,861,651	1/19/1999	Brasen, et al.			
	5,679,965	10/21/1997	Schetzina			
	5,670,798	9/23/1997	Schetzina			
	5,561,302	10/1/1996	Candelaria			
	5,471,948	12/5/1995	Burroughes, et al.			
	5,459,346	10/17/1995	Asakawa, et al.			
	5,391,510	2/21/1995	Hsu, et al.			
	5,371,399	12/6/1994	Burroughes, et al.			
	5,108,843	4/28/1992	Ohtaka, et al.			
	5,060,030	10/22/1991	Hoke			
	4,958,213	9/18/1990	Eklund, et al.			
	4,665,415	5/12/1987	Esaki, et al.			
						

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EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPRO.)
S	5,989,978	11/23/1999	Peidous			
S	6,284,626	9/4/2001	Kim			
S	6,274,444	8/14/2001	Wang			
S	6,261,964	7/17/2001	Wu, et al.			
S	6,221,735	4/24/2001	Manley, et al.			
S	6,117,722	9/12/2000	Wuu, et al.			
S	6,107,143	8/22/2000	Park, et al.			
S	6,090,684	7/18/2000	Ishitsuka, et al.			
S	6,066,545	5/23/2000	Doshi, et al.			
S	6,008,126	12/28/1999	Leedy			
S	5,946,559	8/31/1999	Leedy			
S	5,840,593	11/24/1998	Leedy			
S	5,592,018	1/7/1997	Leedy			
S	5,592,007	1/7/1997	Leedy			
S	5,571,741	11/5/1996	Leedy			

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<i>S</i>	5,557,122	9/17/1996	Shrivastava, et al.			
<i>S</i>	5,354,695	10/11/1994	Leedy			
<i>S</i>	5,134,085	7/28/1992	Gilgen, et al.			
<i>S</i>	5,006,913	4/9/1991	Sugahara, et al.			
<i>S</i>	4,952,524	8/28/1990	Lee, et al.			
<i>S</i>	4,855,245	8/8/1989	Neppl, et al.			
<i>S</i>	2002/0086497	07-04-2002	Kwok			
<i>S</i>	5,960,297	09-28-1999	Saki			
<i>S</i>	6,403,486	06-11-2002	Lou			
<i>S</i>	6,284,623	09-04-2001	Zhang et al.			
<i>S</i>	2003/0032261	02-13-2003	Yeh et al.			
<i>S</i>	2003/0057184	03-27-2003	Yu et al.			
<i>S</i>	6,265,317	07-24-2001	Chiu et al.			
<i>S</i>	2003/0067035	04-10-2003	Tews et al.			
<i>S</i>	6,461,936	10-08-2002	von Ehrenwall			
<i>S</i>	6,319,794	11-20-2001	Akatsu et al.			
<i>S</i>	2001/0009784	07-26-2001	Ma et al.			
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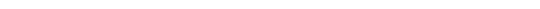
EXAMINER	<i>S</i> <i>AK</i>	DATE CONSIDERED	<i>11/23/08</i>
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Form PTC-1449 (Modified)	Attorney Docket No.: FIS920030246	Serial No.: Unassigned
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Page 1 of 1	Group: Unassigned	

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<i>S</i>	Kern Rim, et al., "Transconductance Enhancement in Deep Submicron Strained-Si <i>n</i> -MOSFETs", International Electron Devices Meeting, 26, 8, 1, IEEE, September 1998.
<i>R</i>	Kern Rim, et al., "Characteristics and Device Design of Sub-100 nm Strained Si N- and PMOSFETs", 2002 Symposium On VLSI Technology Digest of Technical Papers, IEEE, pp 98-99.
<i>S</i>	Gregory Scott, et al., "NMOS Drive Current Reduction Caused by Transistor Layout and Trench Isolation Induced Stress", International Electron Devices Meeting, 34.4.1, IEEE, September 1999.
<i>S</i>	F. Ootsuka, et al., "A Highly Dense, High-Performance 130nm node CMOS Technology for Large Scale System-on-a-Chip Application", International Electron Devices Meeting, 23.5.1, IEEE, April 2000.
<i>S</i>	Shinya Ito, et al., "Mechanical Stress Effect of Etch-Stop Nitride and its Impact on Deep Submicron Transistor Design", International Electron Devices Meeting, 10.7.1, IEEE, April 2000.
<i>S</i>	A. Shimizu, et al., "Local Mechanical-Stress Control (LMC): A New Technique for CMOS-Performance Enhancement", International Electron Devices Meeting, IEEE, March 2001.
<i>S</i>	K. Ota, et al., "Novel Locally Strained Channel Technique for high Performance 55nm CMOS", International Electron Devices Meeting, 2.2.1, IEEE, February 2002.

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